






1 LCOI: Local crystalline orientation identifier using 2 mask fitting implemented in MATLAB

3 Snir Meiri ¹ and Efi Efrati ¹

4 ¹ Department of Physics of Complex Systems, Weizmann Institute of Science, Rehovot 76100, Israel

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Software

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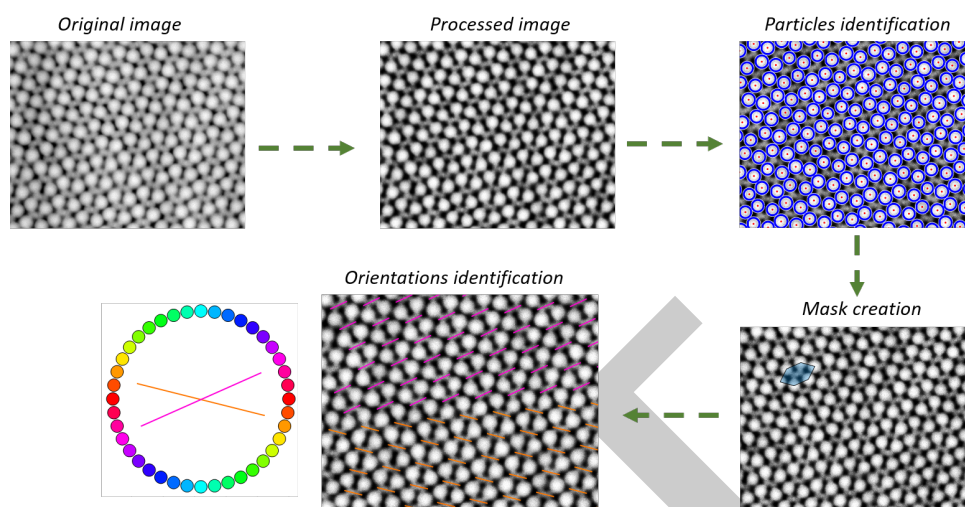
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5 Statement of need

6 Detection and analysis of the orientation of local crystalline order arises in different
7 fields such as chemistry, materials science and condensed matter physics. In particular,
8 such analysis is central for studying crystal melting, jamming, crystal twinning and
9 crystal strains, among others. Although the local orientations can be deduced from the
10 diffraction data ([Angel et al., 2015](#); [Busing & Levy, 1967](#); [Zaefferer, 2011](#)), such analysis
11 must take some spatial averages. The standard tool used for deducing the orientations a
12 set of identified particles in imaging data is bond-orientational order parameter. It has
13 various shortcomings ([Mickel et al., 2013](#)), including restriction to isotropic lattices, high
14 sensitivity to defects and lack of robustness to noise, where small location shifts can lead
15 to abrupt jumps in the identified directionality. While some works focus on correcting the
16 definition of the order parameter ([Mickel et al., 2013](#)), we propose a different approach
17 based on optimal fitting of a mask of a specific shape to the detected particles. Within
18 this approach, the resulting directionality is continuous and robust to local noise. The
19 accuracy in mask orientation detection is primarily limited by the accuracy of the particle
20 location detection.

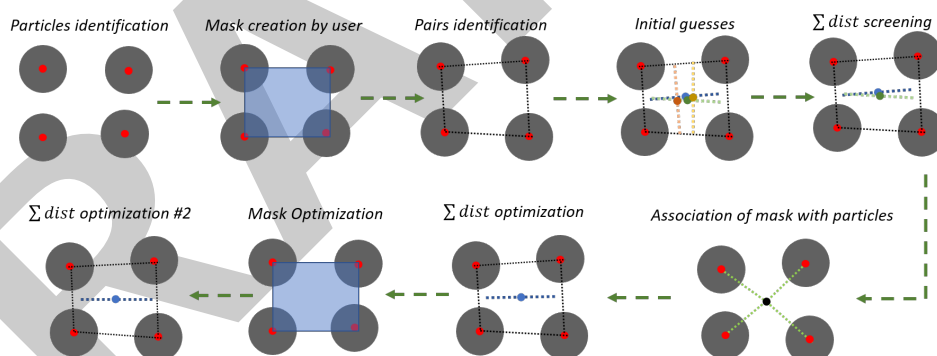
23 Summary

24 LCOI is designed to extract orientation information about local crystalline order from
25 microscopy images such as transmission electron microscopy (TEM). Specifically, the
26 software is able to identify triangular, rectangular and hexagonal order within planar
27 cross-sections of colloidal crystals. The orientation identification is based on mask
28 fitting to the identified particles. The software, implemented as a MATLAB application,
29 allows the user various tools including basic image processing, particles identification,
30 mask creation and fitting, orientations analysis and strain measurements in the
31 crystal. The following figure summarizes the general flow of the identification process:



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After loading the image and optional contrast adjustment the user should first apply particle detection or upload pre-identified data. Then, the user creates a mask (hull) by manually choosing particles of the desired symmetry and the mask is symmetrized by the software. The options are triangular, rectangular and hexagonal, where the last two can either have 2-fold symmetry or 4-fold and 6-fold, respectively. Next, the local orientation of the optimal fits of the created mask to the identified particles is detected and color-coded. A more detailed scheme of the orientation detection is:



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After particles identification and mask creation the following step is particles pairs identification by considering all particles below a distance threshold set by considering the created mask. Then, a fitting mask is located as if each pair corresponds to an edge of the mask. These initial guesses are screened for the sum of the distances to the closest particles to each mask's vertex. Next, for the screened masks' location and orientation, the particle associated with each mask's vertex is identified and the optimal location and orientation is computed analytically. For more details see the attached file: Mask location and rotation optimization. Finally, the mask can be adjusted using all found fits by taking the means of the relevant distances and the updated optimal location and orientation are recomputed.

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References

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